High-q microring resonator with narrow free spectral range for pulse repetition rate multiplication

Pu, Minhao; Ji, Hua; Frandsen, Lars Hagedorn; Galili, Michael; Oxenløwe, Leif Katsuo; Hvam, Jørn Märcher

Published in:
Conference proceedings, CLEO/IQEC

Publication date:
2009

Document Version
Publisher's PDF, also known as Version of record

[Link back to DTU Orbit](#)

Citation (APA):

Pu, M., Ji, H., Frandsen, L. H., Galili, M., Oxenløwe, L. K., & Hvam, J. M. (2009). High-q microring resonator with narrow free spectral range for pulse repetition rate multiplication. In *Conference proceedings, CLEO/IQEC* (pp. CThBB7). IEEE.

General rights

Copyright and moral rights for the publications made accessible in the public portal are retained by the authors and/or other copyright owners and it is a condition of accessing publications that users recognise and abide by the legal requirements associated with these rights.

- Users may download and print one copy of any publication from the public portal for the purpose of private study or research.
- You may not further distribute the material or use it for any profit-making activity or commercial gain
- You may freely distribute the URL identifying the publication in the public portal

If you believe that this document breaches copyright please contact us providing details, and we will remove access to the work immediately and investigate your claim.

High-Q Microring Resonator with Narrow Free Spectral Range for Pulse Repetition Rate Multiplication

Minhao Pu, Hua Ji, Lars H. Frandsen, Michael Galili, Leif K. Oxenløwe, Jørn M. Hvam

DTU Fotonik, Department of Photonics Engineering, Technical University of Denmark, DK-2800 Lyngby, Denmark

mipu@fotonik.dtu.dk

Abstract: We demonstrate a silicon-on-insulator microring resonator with a free-spectral-range of 0.32nm, an extinction ratio of 27dB, and a quality factor of ~ 140900 at 1550nm that is used for pulse repetition-rate multiplication from 10 to 40GHz.

©2009 Optical Society of America

OCIS codes: (130.3120) Integrated optics devices; (230.5750) Resonators; (120.7370) Filters;

1. Introduction

Integrated optical microring resonators can be applied to achieve a broad range of on-chip functionalities such as filtering, modulating, switching, etc. [1]. Recently, the spectrally periodic filtering characteristics of microrings have received increasing interests for pulse repetition-rate multiplication (PRRM) in optical communication systems [2, 3]. Fabry-Perot filters [4] and fiber Bragg gratings [5] have already been utilized for realizing PRRM. However, these devices are bulky, sensitive to ambient conditions, and not suitable for on-chip integration. In this paper, a microring resonator fabricated in silicon-on-insulator (SOI) material using CMOS compatible technologies is used for the first time to obtain PRRM of an optical 10GHz pulse train to 40GHz. This device is easily integrated with photonic and electronic circuits and offers a stable filtering characteristic.

2. Design and fabrication

The microring resonator is designed to have a nominal free-spectral-range (FSR) of 40GHz. This requires the bending radius of the silicon ring to be 250 μ m. The ring is directionally coupled to two waveguides guiding light to and from the ring as shown in fig. 1(a). The cross section of the ring and the waveguides is 420nm $\times$ 340nm. The gaps between the ring and the waveguides in the coupling regions are 440nm and 470nm for the through port and the drop port, respectively. Figure 1(b) shows a scanning electron micrograph (SEM) image of the coupling region between the through port and the microring. The gaps in the coupling regions are designed to be wider than the waveguide widths in order to make the coupling relatively weak providing a higher extinction ratio at the drop port. The microring resonator is fabricated in SOI material having a top silicon thickness of 340nm and a 1 μ m buried silicon dioxide. Diluted (1:1 in anisole) electron-beam resist ZEP520A was spin-coated on the wafer to create a $\sim$ 110nm-thick masking layer. The microring structure was defined in the ZEP520A layer by utilizing electron-beam lithography (JEOL JBX-9300FS). The patterns were subsequently transferred to the top silicon layer by employing inductively coupled plasma reactive ion etching. A top cladding of $\sim$ 1 μ m oxide was deposited as a last step.

Fig. 1. (a) Top-view optical microscope picture of the fabricated microring resonator. (b) Scanning electron micrograph picture of the coupling region between the through port and the microring. (c) Transmission spectrum of the microring resonator recorded at the drop port.

A tunable (1480nm to 1580nm) continuous wave laser was used to record the transmission spectrum of the microring resonator. Figure 1(c) shows the output power of the quasi-transverse magnetic (TM) mode versus wavelength for the drop port. The average FSR of the fabricated microring resonator is 41.2GHz. The extinction ratio is $\sim$ 27dB and the 3dB-bandwidth is $\sim$ 0.01nm which corresponds to a quality factor of ~ 140900 at 1550nm. At resonances, the insertion loss of the microring is $\sim$ 22.5dB for the drop port. This includes the loss from the filter and the fiber-to-waveguide coupling losses, which are estimated to $\sim$ 7dB/facet in the setup used. The coupling from fiber-to-chip can be improved by using e.g. nanotapered couplers. The filter loss includes the coupling losses

between the waveguides and the ring and the propagation loss $\sim 0.32\text{dB/mm}$ for the quasi-TM mode. In this way, the round-trip loss of the ring is estimated to be 0.5dB .

3. Experiment

The characterization setup is schematically shown in fig. 2. The tunable mode-locked laser (TMLL) is used to generate a pulse train at a desired central wavelength from 1480 nm to 1580 nm with a repetition-rate corresponding to one quarter of the FSR of the microring. The output pulse train from the microring is monitored using an optical spectral analyzer (OSA), an electrical spectrum analyzer (ESA), and an optical sampling oscilloscope (OSC).

Fig.2. Experimental setup for pulse repetition rate multiplication experiment

A 10.307GHz pulse train (fig. 3(c)) with central wavelength 1549.56 nm (fig. 3(a)) is sent through the microring resonator and as shown in fig. 3(d) a 41.2 GHz pulse train is obtained. From figs. 3(a) and (b), we can see that most

Fig. 3. Optical spectrum of the (a) 10GHz , (b) 40GHz pulse train and temporal trace of the (c) 10GHz , (d) 40GHz pulse train.

of the phase-locked 40 GHz components in the 10GHz comb corresponding to the input pulse train are transmitted to the drop port by the microring resonator. By measuring the electrical power spectrum, it is found that the 40GHz component is 21.4dB stronger in amplitude than the 10GHz component. The original 10GHz pulses are 2.27ps (full-width half-maximum). After PRRM to 40GHz , the pulse width is 2.45ps which is a broadening of less than 10% . The temporal trace (fig. 3(d)) shows that the 40GHz pulse train has an amplitude envelope and that the pulses suffer $\sim 1\text{dB}$ loss per round-trip in the ring. The propagation loss of the ring contributes with a loss of 0.5dB and the coupling between the ring and waveguides contributes with another 0.5dB . The variation in pulse amplitudes can be reduced by decreasing the propagation loss by e.g. using a post thermal oxidation in the fabrication process or it can be improved by reducing the coupling between ring and waveguides, but at the expense of increased insertion loss of the filter. We have measured that the microring can tolerate up to 10MHz mismatch between the input repetition rate and the FSR of the filter. Clean pulse trains are obtained but the pulse width increases to 3.28 ps by detuning the input repetition rate 10MHz from the optimum match to the FSR. The pulses are broadened due to suboptimum filtering of the 10GHz modes resulting in a narrowing of the optical spectrum of the pulses.

5. Conclusion

We have demonstrated a compact integrated microring resonator in SOI material with 0.32nm FSR, an extinction ratio of 27dB , and a quality factor of ~ 140900 around 1550 nm . To our knowledge this is the first experimental demonstration of an SOI microring used as an inherently stable passive optical pulse multiplier. We have demonstrated the generation of a 40GHz pulse train from a 10GHz input using this device, and we believe that the integrated microring resonator will be an important device in future high-speed optical communication systems.

6. Reference

- [1] K.J. Vahala, "Optical microcavities", *Nature* **424**, 839 (2003).
- [2] B. Xia and L. R. Chen, "A direct temporal domain approach for pulse-repetition rate multiplication with arbitrary envelope shaping", *Selected Topics in Quantum Electronics, IEEE Journal of* **11**, 165-172 (2005).
- [3] M. A. Preciado and M. A. Muriel, "Repetition-rate multiplication using a single all-pass optical cavity", *Opt. Lett.* **33**, 962-964 (2008).
- [4] K. Yiannopoulos, K. Vysokinos, E. Kehayas, N. Pleros, K. Vlachos, H. Avramopoulos and G. Guekos, "Rate Multiplication by Double-Passing Fabry-Perot Filtering", *Photonics Technology Letters, IEEE* **15**, 1294-1296 (2003).
- [5] P. Petropoulos, M. Ibsen, M.N. Zervas, and D.J. Richardson, "Generation of a 40-GHz pulse stream by pulse multiplication with a sampled fiber Bragg grating," *Opt. Lett.* **25**, 521-523 (2000).